# **5 V ECL 8-Bit Ripple Counter**

### Description

The MC10E/100E137 is a very high speed binary ripple counter. The two least significant bits were designed with very fast edge rates while the more significant bits maintain standard ECLinPS<sup>TM</sup> output edge rates. This allows the counter to operate at very high frequencies while maintaining a moderate power dissipation level.

The device is ideally suited for multiple frequency clock generation as well as a counter in a high performance ATE time measurement board.

Both asynchronous and synchronous enables are available to maximize the device's flexibility for various applications. The asynchronous enable input, A\_Start, when asserted enables the counter while overriding any synchronous enable signals. The E137 features XORed enable inputs, EN1 and EN2, which are synchronous to the CLK input. When only one synchronous enable is asserted the counter becomes disabled on the next CLK transition; all outputs remain in the previous state poised for the other synchronous enable or A\_Start to be asserted to re-enable the counter. Asserting both synchronous enables causes the counter to become enabled on the next transition of the CLK. If EN1 (or EN2) and CLK edges are coincident, sufficient delay has been inserted in the CLK path (to compensate for the XOR gate delay and the internal D-flip flop setup time) to insure that the synchronous enable signal is clocked correctly, hence, the counter is disabled.

All input pins left open will be pulled LOW via an input pulldown resistor. Therefore, do not leave the differential CLK inputs open. Doing so causes the current source transistor of the input clock gate to become saturated, thus upsetting the internal bias regulators and jeopardizing the stability of the device.

The asynchronous Master Reset resets the counter to an all zero state upon assertion.

The  $V_{BB}$  pin, an internally generated voltage supply, is available to this device only. For single-ended input conditions, the unused differential input is connected to  $V_{BB}$  as a switching reference voltage.  $V_{BB}$  may also rebias AC coupled inputs. When used, decouple  $V_{BB}$  and  $V_{CC}$  via a  $0.01~\mu F$  capacitor and limit current sourcing or sinking to 0.5~mA. When not used,  $V_{BB}$  should be left open.

The 100 Series contains temperature compensation.

#### **Features**

- Differential Clock Input and Data Output Pins
- V<sub>BB</sub> Output for Single-Ended Use
- Synchronous and Asynchronous Enable Pins
- Asynchronous Master Reset
- PECL Mode Operating Range:
  - $V_{CC} = 4.2 \text{ V to } 5.7 \text{ V with } V_{EE} = 0 \text{ V}$
- NECL Mode Operating Range:
  - $V_{CC} = 0 \text{ V}$  with  $V_{EE} = -4.2 \text{ V}$  to -5.7 V
- Internal Input 50 kΩ Pull-down Resistors
- Transistor Count = 330 devices
- ESD Protection:



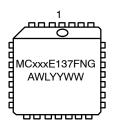
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PLCC-28 FN SUFFIX CASE 776-02

### **MARKING DIAGRAM\***



xxx = 10 or 100

A = Assembly Location

WL = Wafer Lot YY = Year WW = Work Week

\*For additional marking information, refer to Application Note <u>AND8002/D</u>.

= Pb-Free Package

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
MC10E137FNG	PLCC-28 (Pb-Free)	37 Units/Tube
MC100E137FNG	PLCC-28 (Pb-Free)	37 Units/Tube

♦ Human Body Model: > 2 kV

♦ Machine Model: > 200 V

 Meets or Exceeds JEDEC Spec EIA/JESD78 IC Latchup Test

• Moisture Sensitivity Level: 3 (Pb-Free)

 ◆ For Additional Information, see Application Note AND8003/D

 Flammability Rating: UL 94 V-0 @ 0.125 in, Oxygen Index: 28 to 34

 These Devices are Pb-Free, Halogen Free and are RoHS Compliant

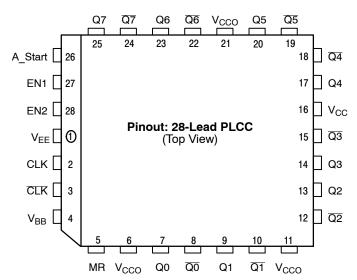


Table 1. PIN DESCRIPTION

PIN	FUNCTION
CLK, CLK	ECL Differential Clock Inputs
Q0-Q7, <del>Q0-Q7</del>	ECL Differential Q Outputs
A_Start	ECL Asynchronous Enable Input
EN1, EN2	ECL Synchronous Enable Inputs
MR	Asynchronous Master Reset
$V_{BB}$	Reference Voltage Output
V <sub>CC</sub> , V <sub>CCO</sub>	Positive Supply
V <sub>EE</sub>	Negative Supply

\* All  $V_{CC}$  and  $V_{CCO}$  pins are tied together on the die.

Warning: All  $V_{CC}$ ,  $V_{CCO}$ , and  $V_{EE}$  pins must be externally connected to Power Supply to guarantee proper operation.

Figure 1. 28-Lead Pinout

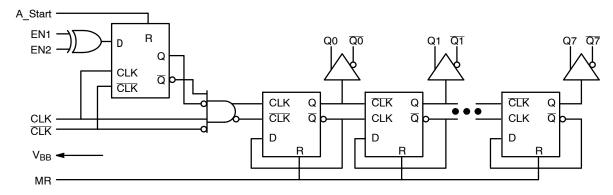


Figure 2. Logic Diagram

**Table 2. SEQUENTIAL TRUTH TABLE** 

Function	EN1	EN2	A_Start	MR	CLK	Q7	Q6	Q5	Q4	Q3	Q2	Q1	Q0
Reset	Х	Х	Х	Н	Х	L	L	L	L	L	L	L	L
Count	L	L	L	L	Z	L	L	L	L	L	L	L	H
	L	L	L	L	Z	L	L	L	L	L	L	H	L
	L	L	L	L	Z	L	L	L	L	L	L	H	H
Stop	H	L L	L L	L L	Z Z	L L	L L	L L	L L	L L	L L	H	H
Asynch Start	H	L	H	L	Z	L	L	L	L	L	H	L	L
	H	L	H	L	Z	L	L	L	L	L	H	L	H
	L	L	H	L	Z	L	L	L	L	L	H	H	L
Count	L	L	L	L	Z	L	L	L	L	L	H	H	H
	L	L	L	L	Z	L	L	L	L	H	L	L	L
	L	L	L	L	Z	L	L	L	L	H	L	L	H
Stop	L	H	L	L	Z	L	L	L	L	H	L	L	H
	L	H	L	L	Z	L	L	L	L	H	L	L	H
Synch Start	H	H	L	L	Z	L	L	L	L	H	L	H	L
	H	H	L	L	Z	L	L	L	L	H	L	H	H
	H	H	L	L	Z	L	L	L	L	H	H	L	L
Stop	H	L L	L L	L L	Z Z	L L	L L	L L	L L	H H	H H	L L	L L
Count	L	L	L	L	Z	L	L	L	L	H	H	L	H
	L	L	L	L	Z	L	L	L	L	H	H	H	L
	L	L	L	L	Z	L	L	L	L	H	H	H	H
Reset	Х	Х	Х	Н	Χ	L	L	L	L	L	L	L	L

Z = Low to High Transition

**Table 3. MAXIMUM RATINGS** 

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V <sub>CC</sub>	PECL Mode Power Supply	V <sub>EE</sub> = 0 V		8	V
V <sub>EE</sub>	NECL Mode Power Supply	V <sub>CC</sub> = 0 V		-8	V
VI	PECL Mode Input Voltage NECL Mode Input Voltage	V <sub>EE</sub> = 0 V V <sub>CC</sub> = 0 V	$V_{I} \leq V_{CC}$ $V_{I} \geq V_{EE}$	6 -6	V
I <sub>out</sub>	Output Current	Continuous Surge		50 100	mA
T <sub>A</sub>	Operating Temperature Range			0 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			-65 to +150	°C
$\theta_{JA}$	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm	PLCC-28	63.5 43.5	°C/W
θЈС	Thermal Resistance (Junction-to-Case)	Standard Board	PLCC-28	22 to 26	°C/W
V <sub>EE</sub>	PECL Operating Range NECL Operating Range			4.2 to 5.7 -5.7 to -4.2	V
T <sub>sol</sub>	Wave Solder (Pb-Free)			265	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 4. 10E SERIES PECL DC CHARACTERISTICS (V<sub>CCx</sub> = 5.0 V; V<sub>EE</sub> = 0.0 V (Note 1))

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		121	145		121	145		121	145	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 2)	3980	40 70	4160	4020	4105	4190	4090	4185	4280	mV
V <sub>OL</sub>	Output LOW Voltage (Note 2)	3050	3210	3370	3050	3210	3370	3050	3227	3405	mV
V <sub>IH</sub>	Input HIGH Voltage (Single-Ended)	3830	3995	4160	3870	4030	4190	3940	4110	4280	mV
V <sub>IL</sub>	Input LOW Voltage (Single-Ended)	3050	3285	3520	3050	3285	3520	3050	3302	3555	mV
V <sub>BB</sub>	Output Voltage Reference	3.62		3.73	3.65		3.75	3.69		3.81	V
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3)	2.2		4.6	2.2		4.6	2.2		4.6	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5	0.3		0.5	0.25		0.3	0.2		μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 1. Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary -0.46~V / +0.06~V.
- 2. Outputs are terminated through a 50  $\Omega$  resistor to  $V_{CC}$  2.0 V.
- 3.  $V_{IHCMR}$  min varies 1:1 with  $V_{EE}$ , max varies 1:1 with  $V_{CC}$ .

Table 5. 10E SERIES NECL DC CHARACTERISTICS ( $V_{CCx} = 0.0 \text{ V}$ ;  $V_{EE} = -5.0 \text{ V}$  (Note 1))

		0°C				25°C		85°C			
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		121	145		121	145		121	145	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 2)	-1020	-930	-840	-980	-895	-810	-910	-815	-720	mV
V <sub>OL</sub>	Output LOW Voltage (Note 2)	-1950	-1790	-1630	-1950	-1790	-1630	-1950	-1773	-1595	mV
V <sub>IH</sub>	Input HIGH Voltage (Single-Ended)	-1170	-1005	-840	-1130	-970	-810	-1060	-890	-720	mV
V <sub>IL</sub>	Input LOW Voltage (Single-Ended)	-1950	-1715	-1480	-1950	-1715	-1480	-1950	-1698	-1445	mV
V <sub>BB</sub>	Output Voltage Reference	-1.38		-1.27	-1.35		-1.25	-1.31		-1.19	V
VIHCMR	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3)	-2.8		-0.4	-2.8		-0.4	-2.8		-0.4	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
Ι <sub>ΙL</sub>	Input LOW Current	0.5	0.3		0.5	0.065		0.3	0.2		μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 1. Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary -0.46~V / +0.06~V.
- 2. Outputs are terminated through a 50  $\Omega$  resistor to  $V_{CC}$  2.0 V.
- 3. V<sub>IHCMR</sub> min varies 1:1 with V<sub>EE</sub>, max varies 1:1 with V<sub>CC</sub>.

Table 6. 100E SERIES PECL DC CHARACTERISTICS (V<sub>CCx</sub> = 5.0 V; V<sub>EE</sub> = 0.0 V (Note 1))

		0°C				25°C		85°C			
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		121	145		121	145		139	167	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 2)	3975	4050	4120	3975	4050	4120	3975	4050	4120	mV
V <sub>OL</sub>	Output LOW Voltage (Note 2)	3190	3295	3380	3190	3255	3380	3190	3260	3380	mV
V <sub>IH</sub>	Input HIGH Voltage (Single-Ended)	3835	3975	4120	3835	3975	4120	3835	3975	4120	mV
$V_{IL}$	Input LOW Voltage (Single-Ended)	3190	3355	3525	3190	3355	3525	3190	3355	3525	mV
$V_{BB}$	Output Voltage Reference	3.62		3.73	3.62		3.74	3.62		3.74	V
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3)	2.2		4.6	2.2		4.6	2.2		4.6	V
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5	0.3		0.5	0.25		0.5	0.2		μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 1. Input and output parameters vary 1:1 with  $V_{CC}$ .  $V_{EE}$  can vary -0.46 V / +0.8 V.
- 2. Outputs are terminated through a 50  $\Omega$  resistor to VCC 2.0 V.
- 3.  $V_{IHCMR}$  min varies 1:1 with  $V_{EE}$ , max varies 1:1 with  $V_{CC}$ .

Table 7. 100E SERIES NECL DC CHARACTERISTICS (V<sub>CCx</sub> = 0.0 V; V<sub>EE</sub> = -5.0 V (Note 1))

		0°C				25°C		85°C			
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>EE</sub>	Power Supply Current		121	145		121	145		139	167	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 2)	-1025	-950	-880	-1025	-950	-880	-1025	-950	-880	mV
V <sub>OL</sub>	Output LOW Voltage (Note 2)	-1810	-1705	-1620	-1810	-1745	-1620	-1810	-1740	-1620	mV
V <sub>IH</sub>	Input HIGH Voltage (Single-Ended)	-1165	-1025	-880	-1165	-1025	-880	-1165	-1025	-880	mV
V <sub>IL</sub>	Input LOW Voltage (Single-Ended)	-1810	-1645	-1475	-1810	-1645	-1475	-1810	-1645	-1475	mV
V <sub>BB</sub>	Output Voltage Reference	-1.38		-1.27	-1.38		-1.26	-1.38		-1.26	V
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3)	-3.8		-0.4	-3.8		-0.4	-3.8		-0.4	٧
I <sub>IH</sub>	Input HIGH Current			150			150			150	μΑ
I <sub>IL</sub>	Input LOW Current	0.5	0.3		0.5	0.25		0.5	0.2		μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 1. Input and output parameters vary 1:1 with V $_{CC}$ . V $_{EE}$  can vary -0.46 V / +0.8 V. 2. Outputs are terminated through a 50  $\Omega$  resistor to V $_{CC}$  2.0 V.
- 3.  $V_{IHCMR}$  min varies 1:1 with  $V_{EE}$ , max varies 1:1 with  $V_{CC}$ .

Table 8. AC CHARACTERISTICS ( $V_{CCx} = 5.0 \text{ V}$ ;  $V_{EE} = 0.0 \text{ V}$  or  $V_{CCx} = 0.0 \text{ V}$ ;  $V_{EE} = -5.0 \text{ V}$  (Note 1))

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
f <sub>COUNT</sub>	Maximum Count Frequency	1800	2200		1800	2200		1800	2200		MHz
t <sub>PHL</sub>	Propagation Delay to Output CLK to Q0 CLK to Q1 CLK to Q2 CLK to Q3 CLK to Q4 CLK to Q5 CLK to Q6 CLK to Q7 A_Start to Q0 MR to Q0	1300 1600 1950 2275 2625 2950 3250 3575 950 700	1700 2025 2425 2750 3125 3450 3775 4075 1325 1000	2150 2500 2925 3350 3750 4150 4450 4800 1700 1300	1300 1600 1950 2275 2625 2950 3250 3575 950 700	1700 2050 2450 2775 3150 3475 3800 4125 1325 1000	2150 2500 2925 3350 3750 4150 4450 4800 1700 1300	1350 1650 2025 2350 2700 3050 3375 3700 950 700	1750 2100 2500 2850 3225 3550 3925 4250 1325 1000	2200 2550 3000 3425 3825 4250 4600 4950 1700 1300	ps
t <sub>s</sub>	Setup Time (EN1, EN2)	0	-150		0	-150		0	-150		ps
t <sub>h</sub>	Hold Time (EN1, EN2)	300	150		300	150		300	150		ps
t <sub>RR</sub>	Reset Recovery Time MR, A_Start	400	200		400	200		400	200		ps
t <sub>PW</sub>	Minimum Pulse Width CLK, MR, A_Start	400			400			400			ps
V <sub>PP</sub>	Input Voltage Swing CLK/CLK (Differential Configuration) (Note 2)	0.25		1.0	0.25		1.0	0.25		1.0	٧
t <sub>JITTER</sub>	Random Clock Jitter (RMS)		< 1			< 1			< 1		ps
t <sub>r</sub> t <sub>f</sub>	Rise/Fall Times (20%-80%) Q0,Q1 Q2 to Q7	150 275		400 600	150 275		400 600	150 275		400 600	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

<sup>1. 10</sup> Series:  $V_{EE}$  can vary -0.46 V / +0.06 V. 100 Series:  $V_{EE}$  can vary -0.46 V / +0.8 V.

<sup>2.</sup> Minimum input swing for which AC parameters are guaranteed. Full DC ECL output swings will be generated with only 50 mV input swings.

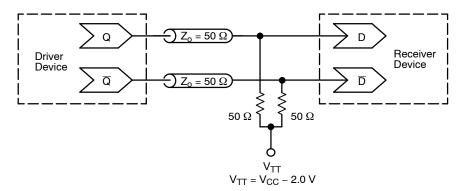


Figure 3. Typical Termination for Output Driver and Device Evaluation (See Application Note <u>AND8020/D</u> – Termination of ECL Logic Devices.)

### **Resource Reference of Application Notes**

AN1405/D - ECL Clock Distribution Techniques

AN1406/D - Designing with PECL (ECL at +5.0 V)

AN1503/D - ECLinPS™ I/O SPICE Modeling Kit

AN1504/D - Metastability and the ECLinPS Family

AN1568/D - Interfacing Between LVDS and ECL

AN1672/D - The ECL Translator Guide

AND8001/D - Odd Number Counters Design

AND8002/D - Marking and Date Codes

AND8020/D - Termination of ECL Logic Devices

AND8066/D - Interfacing with ECLinPS

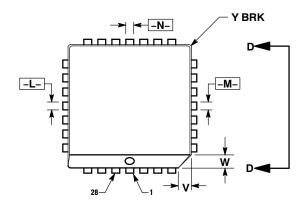
AND8090/D - AC Characteristics of ECL Devices

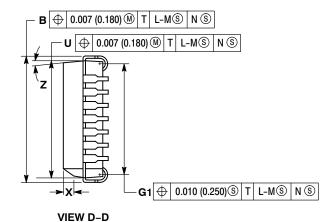


#### 28 LEAD PLLC CASE 776-02 **ISSUE F**

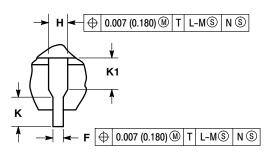
**DATE 29 JUL 2008** 







⊕ | 0.007 (0.180) M | T | L-M S | N S Z ⊕ 0.007 (0.180) M T L-MS N S Ε 0.004 (0.100) \_T\_ SEATING PLANE G1 VIEW S 0.010 (0.250) T L-M N S



## VIEW S

#### NOTES:

- OTES:

  1. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOP OF LEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE.

  2. DIMENSION G1, TRUE POSITION TO BE MEASURED AT DATUM -T-, SEATING PLANE.

  3. DIMENSIONS R AND U DO NOT INCLUDE MOLD FLASH. ALLOWABLE MOLD FLASH IS 0.010 (0.250) PFR SIFE
- 0.010 (0.250) PER SIDE.

  4. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  5. CONTROLLING DIMENSION: INCH.
- THE PACKAGE TOP MAY BE SMALLER THAN
   THE PACKAGE BOTTOM BY UP TO 0.012 THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE
- PLASTIC BODY.

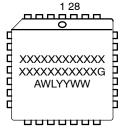
  7. DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN 0.037 (0.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN 0.025 (0.635).

	IIVC	пЕЭ	IVIILLIIV	IEIENO
DIM	MIN	MAX	MIN	MAX
Α	0.485	0.495	12.32	12.57
В	0.485	0.495	12.32	12.57
С	0.165	0.180	4.20	4.57
Е	0.090	0.110	2.29	2.79
F	0.013	0.021	0.33	0.53
G	0.050	BSC	1.27	BSC
Н	0.026	0.032	0.66	0.81
J	0.020		0.51	
K	0.025		0.64	
R	0.450	0.456	11.43	11.58
U	0.450	0.456	11.43	11.58
٧	0.042	0.048	1.07	1.21
W	0.042	0.048	1.07	1.21
X	0.042	0.056	1.07	1.42
Υ		0.020		0.50
Z	2°	10°	2°	10°
G1	0.410	0.430	10.42	10.92
K1	0.040		1.02	

INCHES

MILLIMETEDS

## **GENERIC** MARKING DIAGRAM\*



XXXXX = Specific Device Code = Assembly Location

WL = Wafer Lot YY = Year WW = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present.

DOCUMENT NUMBER:	98ASB42596B	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
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